

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/656,294	CHANG, LIN-WEI	
Examiner		Art Unit		Page 1 of 1
James O. Hansen		3637		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,751,545	05-1998	Jung, Hee-Duck	361/683
	B	US-6,775,144	08-2004	Gan et al.	361/727
	C	US-6,711,009	03-2004	Lee et al.	361/683
	D	US-6,398,325	06-2002	Chen et al.	312/223.2
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	4226951	03-1994	Germany	Diehl	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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